## Notice of References Cited Application/Control No. 09/630,024 Examiner Edan Orgad Applicant(s)/Patent Under Reexamination FARLEY ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,804,528 B1	10-2004	Laroia et al.	455/503
*	В	US-6,188,911 B1	02-2001	Wallentin et al.	455/524
*	С	US-6,353,606 B1	03-2002	Hill et al.	370/342
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	н	US-			
	1	US-			
	۲.	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code		Date MM-YYYY	Country	Name	Classification
	N	Wo 01	82645	01-2001	WO	EMILSSON et al	
	0						
	Р						
	Q						
	R						
	s	•					
	Т						

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.